Search Notes

Application/Control No	Applicant(s)/Patent und Reexamination	er
10/693,737	CHANG ET AL.	
Examiner	Art Unit	
Richard L. Chiesa	1724	

SEARCHED				
Class	Subclass	Date	Examiner	
96	60-63, 95- 97	4/18/2005	RLC	
		- -		
	1			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
PALM Inventors' Names and Assignee (Industrial Technology Research Institute) searches.	4/16/2005	RLC	
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